


<b>Search Notes</b>  	<b>Application/Control No.</b>  10581187	<b>Applicant(s)/Patent Under Reexamination</b>  MOSHE, DANNY S.
	<b>Examiner</b>  SHEELA C CHAWAN	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
382	100, 103, 101, 141, 137, 168	5/20/09	SCC
713	179, 168, 176	5/20/09	SCC
427	8, 256	5/20/09	SCC
359	534,536,900, 534	5/20/09	SCC
380	300, 51, 54, 59	5/20/09	SCC
348	E5.006, E7.06, E7.07	5/20/09	SCC
375	E7.009, E7.024	5/20/09	SCC
340	5.86,5.1,5.8	5/20/09	SCC
106	31.64, 31.15, 31.32	5/20/09	SCC
705	53,57,80	5/20/09	SCC
708	250, 255	5/20/09	SCC
523	161,160	5/20/09	SCC
252	301.35, 301.16	5/20/09	SCC
356	451,452,456	5/20/09	SCC
342	90,22	5/20/09	SCC
250	208.1,	5/20/09	SCC
257	E27.13	5/20/09	SCC

SEARCH NOTES		
Search Notes	Date	Examiner
SEARCH EAST AND OTHER DATA BASE, SEE THE SEARCH HISTORY.	5/20/09	SCC
SEARCH INVENTOR NAME	5/20/09	SCC
382/100,103,101,141,137.ccls.	5/20/09	SCC
713/179,168,176.ccls.	5/20/09	SCC
427/8,256.ccls.	5/20/09	SCC
356/451,452,456.ccls.	5/20/09	SCC
342/22,90.ccls.	5/20/09	SCC
250/208.1.ccls.	5/20/09	SCC
359/534,536,900.CCLS.	5/20/09	SCC
356/300,451,452,456.ccls.	5/20/09	SCC
SEARCH IEEE OR INSPEC DATA BASE	5/20/09	SCC
INTERFERENCE SEARCH	5/20/09	SCC
DISCUS WITH SAMIR AHMED SPE ART UNIT: 2624.	5/20/09	SCC
SEARCH UP-DATE	5/20/09	SCC

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## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
382	100,141, 168	5/20/09	SCC
359	534	5/20/09	SCC
356	456	5/20/09	SCC
427	8	5/20/09	SCC

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